THVD1428 3.3-V to 5-V RS-485 Transceiver with 3-kV Surge Protection

1 Features

- Meets or exceeds the requirements of the TIA/EIA-485A standard
- 3-V to 5.5-V Supply voltage
- Bus I/O protection
  - ± 16 kV HBM ESD
  - ± 4 kV IEC 61000-4-2 Contact discharge
  - ± 8 kV IEC 61000-4-2 Air-gap discharge
  - ± 4 kV IEC 61000-4-4 Electrical fast transient
  - ± 3 kV IEC 61000-4-5 1.2/50-µs Surge
- Supports 20 Mbps
- Extended ambient temperature range: -40°C to 125°C
- Extended operational common-mode range: ± 12 V
- Receiver hysteresis for noise rejection: 30 mV
- Low power consumption
  - Standby supply current: < 2 µA
  - Current during operation: < 3 mA
- Glitch-free power-up/down for hot plug-in capability
- Open, short, and idle bus fail-safe
- 1/8 Unit load (Up to 256 bus nodes)
- Industry standard 8-Pin SOIC for drop-in compatibility

2 Applications

- Wireless infrastructure
- Building automation
- HVAC systems
- Factory automation & control
- Grid infrastructure
- Smart meters
- Process analytics
- Video surveillance

3 Description

THVD1428 is a half-duplex RS-485 transceiver with integrated surge protection. Surge protection is achieved by integrating transient voltage suppressor (TVS) diodes in the standard 8-pin SOIC (D) package. This feature provides a substantial increase in reliability for better immunity to noise transients coupled to the data cable, eliminating the need for external protection components.

This device operates from a single 3.3-V or 5-V supply and features a wide common-mode voltage range which makes it suitable for multi-point applications over long cable runs.

The device is available in the industry standard SOIC package for easy drop-in without any PCB changes. The device is characterized over ambient free-air temperatures from –40°C to 125°C.

Device Information(1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
THVD1428	SOIC (8)	4.90 mm × 3.91 mm

(1) For all available devices, see the orderable addendum at the end of the data sheet.

Block Diagram

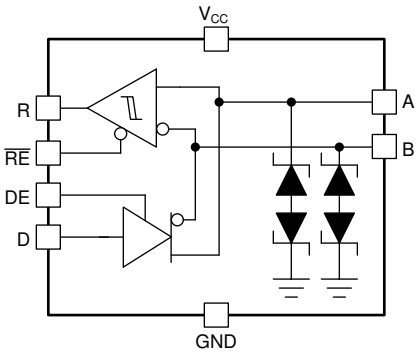


Table of Contents

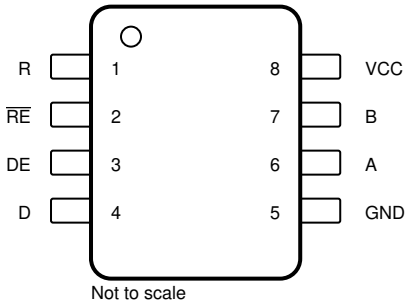
4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
May 2020	*	Initial release.

5 Pin Configuration and Functions

THVD1428 Devices
8-Pin D Package (SOIC)
Top View



Not to scale

Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
A	6	Bus input/output	Bus I/O port, A (complementary to B)
B	7	Bus input/output	Bus I/O port, B (complementary to A)
D	4	Digital input	Driver data input (2-MΩ internal pull-up)
DE	3	Digital input	Driver enable, active high (2-MΩ internal pull-down)
GND	5	Ground	Device ground
R	1	Digital output	Receive data output
V_{CC}	8	Power	3.3-V to 5-V supply
$\overline{RE}$	2	Digital input	Receiver enable, active low (2-MΩ internal pull-up)

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Supply voltage	V_{CC}	-0.5	7	V
Bus voltage	Range at any bus pin (A or B) as differential or common-mode with respect to GND	-15	15	V
Input voltage	Range at any logic pin (D, DE, or /RE)	-0.3	5.7	V
Receiver output current	I_O	-24	24	mA
Storage temperature range		-65	150	℃

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

				VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, 2010	Bus terminals and GND	±16	kV
			All other pins	±8	kV
		Charged device model (CDM), per JEDEC JESD22-C101E	All pins	±1.5	kV

6.3 ESD Ratings - IEC Specifications

				VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Contact Discharge, per IEC 61000-4-2	Bus pins and GND	±4	kV
		Air-Gap Discharge, per IEC 61000-4-2	Bus pins and GND	±8	kV
$V_{(EFT)}$	Electrical fast transient	Per IEC 61000-4-4	Bus pins and GND	±4	kV
$V_{(surge)}$	Surge	Per IEC 61000-4-5, 1.2/50 μs	Bus pins and GND	±3	kV

6.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	3		5.5	V
V_I	Input voltage at any bus terminal (separately or common mode) (1)	-12		12	V
V_{IH}	High-level input voltage (driver, driver enable, and receiver enable inputs)	2		V_{CC}	V
V_{IL}	Low-level input voltage (driver, driver enable, and receiver enable inputs)	0		0.8	V
V_{ID}	Differential input voltage	-12		12	V
I_O	Output current, driver	-60		60	mA
I_{OR}	Output current, receiver	-8		8	mA
R_L	Differential load resistance	54			Ω
$1/t_{UI}$	Signaling rate: THVD1428			20	Mbps
T_A	Operating ambient temperature	-40		125	℃
T_J	Junction temperature	-40		150	℃

(1) The algebraic convention, in which the least positive (most negative) limit is designated as minimum is used in this data sheet.

6.5 Thermal Information

THERMAL METRIC(1)		THVD1428 D (SOIC) 8-PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	120.7	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	50.3	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	62.8	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	7.5	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	62.2	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

6.6 Power Dissipation

PARAMETER	Description	TEST CONDITIONS	VALUE	UNIT
P_D	Driver and receiver enabled, V_{CC} = 5.5 V, T_A = 125 ^{0}C, 50% duty cycle square wave at maximum signaling rate, THVD1428	Unterminated: R_L = 300 Ω, C_L = 50 pF	350	mW
		RS-422 load: R_L = 100 Ω, C_L = 50 pF	290	mW
		RS-485 load: R_L = 54 Ω, C_L = 50 pF	300	mW

6.7 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
Driver							
$\|V_{OD}\|$	Driver differential output voltage magnitude	R_L = 60 Ω, -12 V ≤ V_{test} ≤ 12 V, see Figure 7		1.5	3.5		V
$\|V_{OD}\|$	Driver differential output voltage magnitude	R_L = 60 Ω, -12 V ≤ V_{test} ≤ 12 V, 4.5 V ≤ V_{CC} ≤ 5.5 V, see Figure 7		2.1			V
$\|V_{OD}\|$	Driver differential output voltage magnitude	R_L = 100 Ω, see Figure 8		2	4		V
$\|V_{OD}\|$	Driver differential output voltage magnitude	R_L = 54 Ω, see Figure 8		1.5	3.5		V
$\Delta\|V_{OD}\|$	Change in differential output voltage	R_L = 54 Ω, see Figure 8		-200		200	mV
V_{OC}	Common-mode output voltage			1	V_{CC} / 2	3	V
$\Delta V_{OC(SS)}$	Change in steady-state common-mode output voltage			-200		200	mV
I_{OS}	Short-circuit output current	DE = V_{CC}, -7 V ≤ V_O ≤ 12 V		-250		250	mA
Receiver							
I_I	Bus input current	DE = 0 V, V_{CC} = 0 V or 5.5 V	V_I = 12 V		50	125	µA
			V_I = -7 V	-100	-65		µA
			V_I = -12 V	-150	-100		µA
V_{TH+}	Positive-going input threshold voltage	Over common-mode range of ±12 V		See(1)	-100	-20	mV
V_{TH-}	Negative-going input threshold voltage			-200	-130	See(1)	mV
V_{HYS}	Input hysteresis				30		mV
$C_{A,B}$	Input differential capacitance	Measured between A and B, f = 1 MHz			220		pF
V_{OH}	Output high voltage	I_{OH} = -8 mA		V_{CC} – 0.4	V_{CC} – 0.3		V
V_{OL}	Output low voltage	I_{OL} = 8 mA			0.2	0.4	V
I_{OZR}	Output high-impedance current	V_O = 0 V or V_{CC}, $\overline{RE}$ = V_{CC}		-1		1	µA
Logic							
I_{IN}	Input current (D, DE, $\overline{RE}$)	4.5 V ≤ V_{CC} ≤ 5.5 V		-6.2		6.2	µA
Device							
I_{CC}	Supply current (quiescent)	Driver and receiver enabled	$\overline{RE}$ = 0 V, DE = V_{CC}, No load		2.4	3	mA
		Driver enabled, receiver disabled	$\overline{RE}$ = V_{CC}, DE = V_{CC}, No load		2	2.6	mA
		Driver disabled, receiver enabled	$\overline{RE}$ = 0 V, DE = 0V, No load		700	960	µA
		Driver and receiver disabled	$\overline{RE}$ = V_{CC}, DE = 0 V, D = open, No load		0.1	2	µA
T_{SD}	Thermal shutdown temperature				170		℃

(1) Under any specific conditions, V_{TH+} is assured to be at least V_{HYS} higher than V_{TH-}.

6.8 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Driver: THVD1428						
t_r, t_f	Differential output rise / fall time	R_L = 54 Ω, C_L = 50 pF, see Figure 9		9	16	ns
t_{PHL}, t_{PLH}	Propagation delay			12	25	ns
$t_{SK(P)}$	Pulse skew, $\lvert t_{PHL} - t_{PLH} \rvert$				6	ns
t_{PHZ}, t_{PLZ}	Disable time			18	40	ns
t_{PZH}, t_{PZL}	Enable time	$\overline{RE}$ = 0 V, see Figure 10 and Figure 11		16	40	ns
		$\overline{RE}$ = V_{CC}, see Figure 10 and Figure 11		2.8	11	µs
Receiver: THVD1428						
t_r, t_f	Output rise / fall time	C_L = 15 pF, see Figure 12		2	6	ns
t_{PHL}, t_{PLH}	Propagation delay			12	45	ns
$t_{SK(P)}$	Pulse skew, $\lvert t_{PHL} - t_{PLH} \rvert$				6	ns
t_{PHZ}, t_{PLZ}	Disable time			14	28	ns
$t_{PZH(1)}$, $t_{PZL(1)}$, $t_{PZH(2)}$, $t_{PZL(2)}$,	Enable time	DE = V_{CC}, see Figure 13		75	110	ns
		DE = 0 V, see Figure 14		4.8	14	µs

6.9 Typical Characteristics

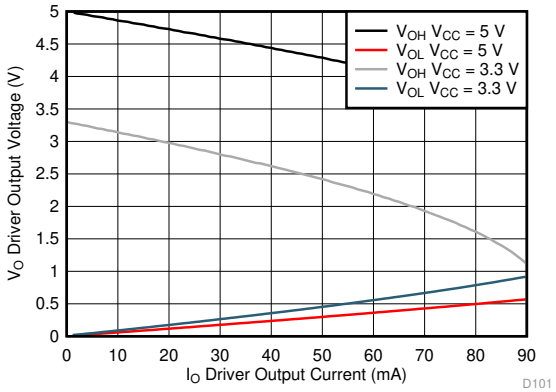


Figure 1. Driver Output Voltage vs Driver Output Current

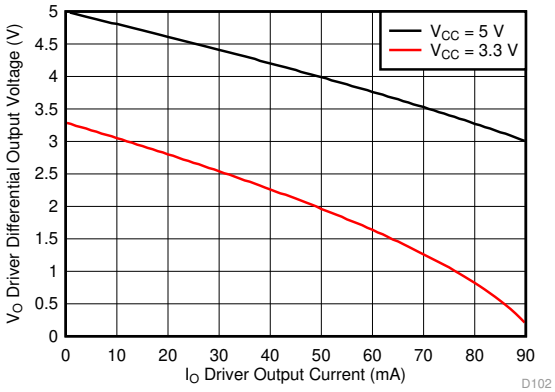


Figure 2. Driver Differential Output voltage vs Driver Output Current

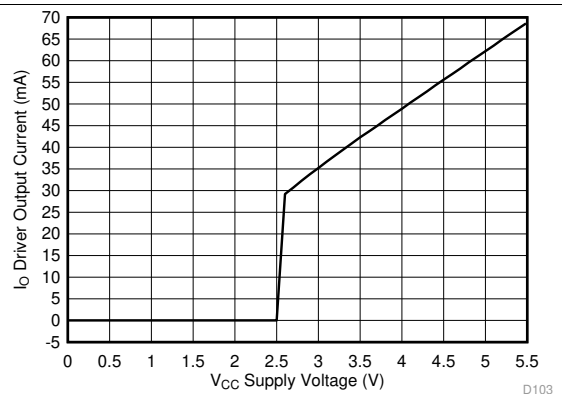


Figure 3. Driver Output Current vs Supply Voltage

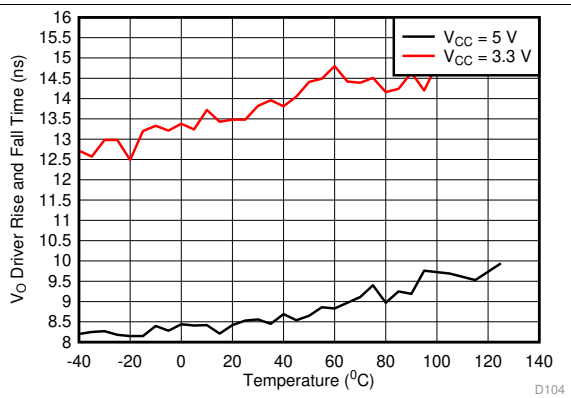


Figure 4. Driver Rise or Fall Time vs Temperature

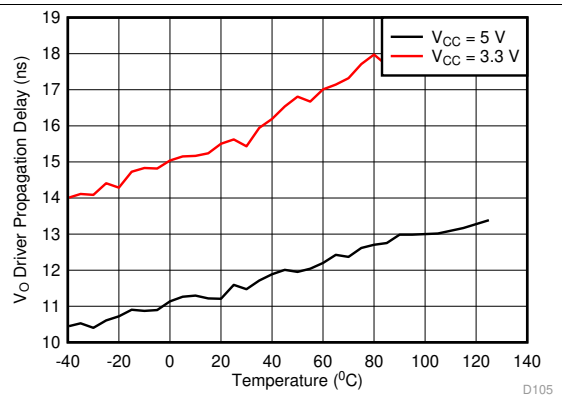


Figure 5. Driver Propagation Delay vs Temperature

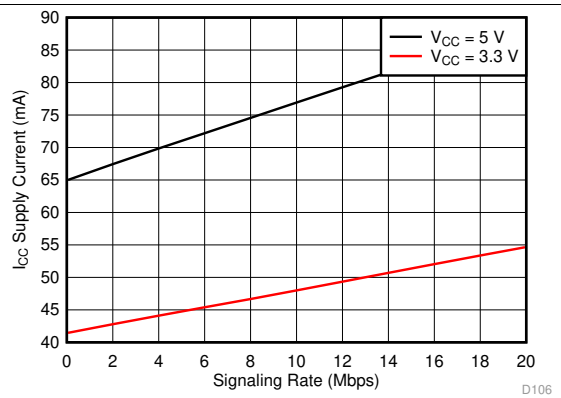


Figure 6. Supply Current vs Signal Rate

7 Parameter Measurement Information

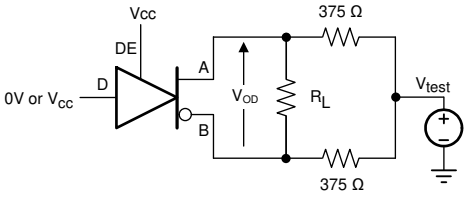


Figure 7. Measurement of Driver Differential Output Voltage With Common-Mode Load

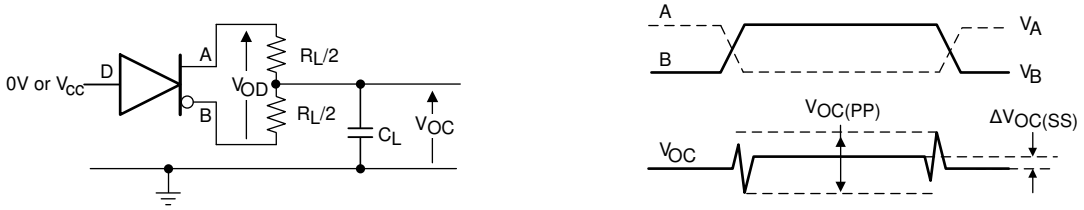


Figure 8. Measurement of Driver Differential and Common-Mode Output With RS-485 Load

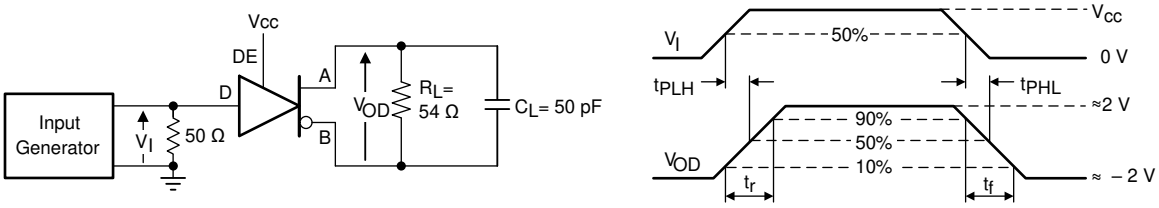


Figure 9. Measurement of Driver Differential Output Rise and Fall Times and Propagation Delays

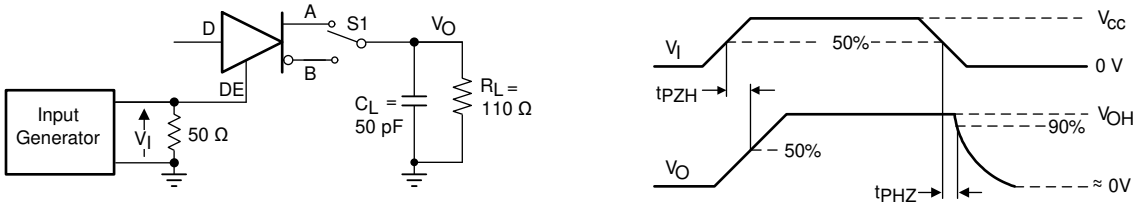


Figure 10. Measurement of Driver Enable and Disable Times With Active High Output and Pull-Down Load

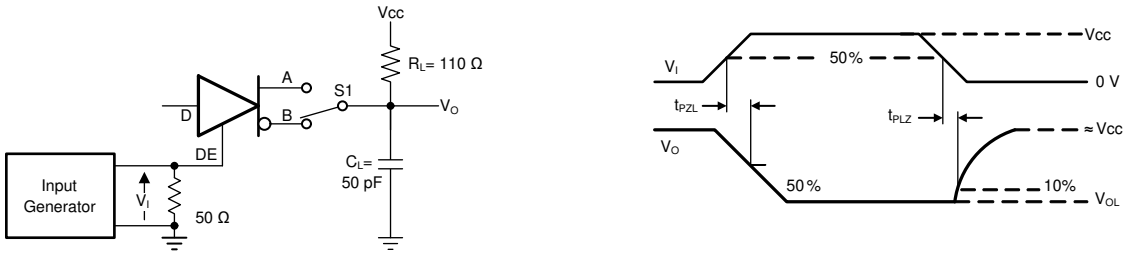


Figure 11. Measurement of Driver Enable and Disable Times With Active Low Output and Pull-up Load

Parameter Measurement Information (continued)

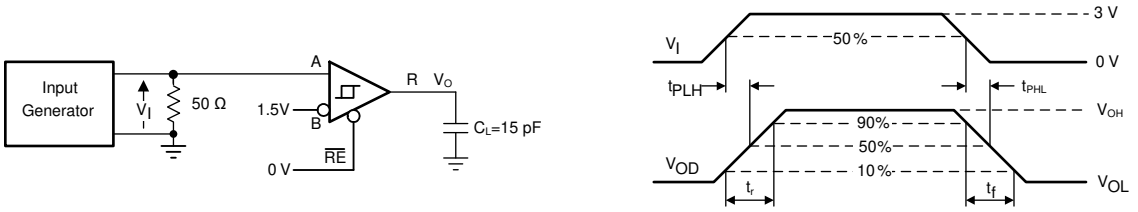


Figure 12. Measurement of Receiver Output Rise and Fall Times and Propagation Delays

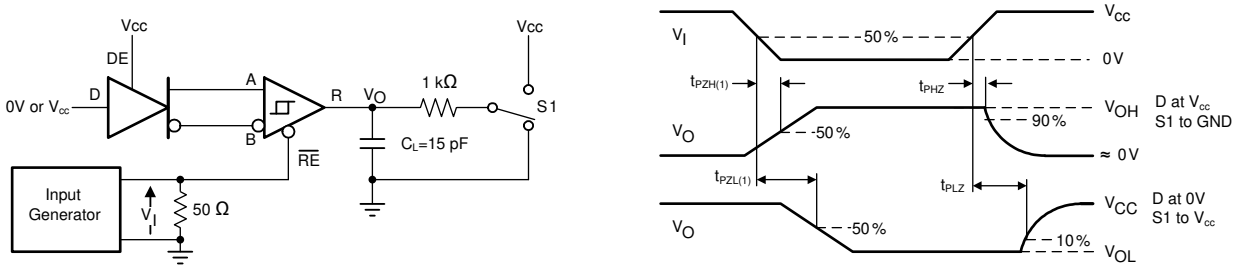


Figure 13. Measurement of Receiver Enable/Disable Times With Driver Enabled

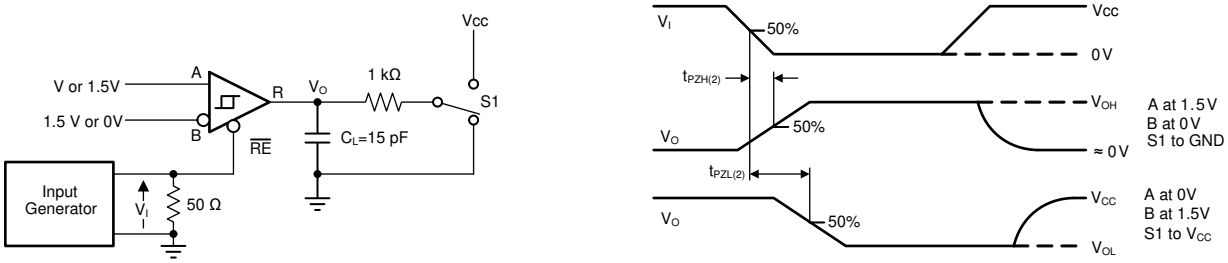


Figure 14. Measurement of Receiver Enable Times With Driver Disabled

8 Detailed Description

8.1 Overview

THVD1428 is surge-protected, half duplex RS-485 transceiver suitable for data transmission up to 20 Mbps. Surge protection is achieved by integrating transient voltage suppresser (TVS) diodes in the standard 8-pin SOIC (D) package.

The device has active-high driver enable and active-low receiver enable. A standby current of less than 2 µA can be achieved by disabling both driver and receiver.

8.2 Functional Block Diagrams

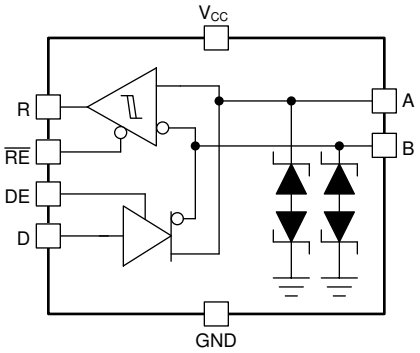


Figure 15. THVD1428 Block Diagram

8.3 Feature Description

8.3.1 Electrostatic Discharge (ESD) Protection

The bus pins of the THVD1428 transceiver includes on-chip ESD protection against ±16-kV HBM and ±4-kV IEC 61000-4-2 contact discharge. The International Electrotechnical Commission (IEC) ESD test is far more severe than the HBM ESD test. The 50% higher charge capacitance, $C_{(S)}$, and 78% lower discharge resistance, $R_{(D)}$, of the IEC model produce significantly higher discharge currents than the HBM model. As stated in the IEC 61000-4-2 standard, contact discharge is the preferred transient protection test method.

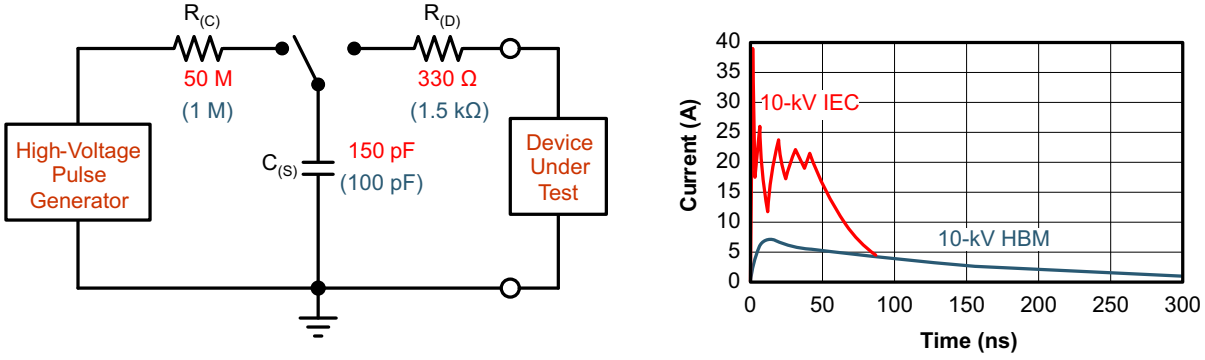


Figure 16. HBM and IEC ESD Models and Currents in Comparison (HBM Values in Parenthesis)

The on-chip implementation of IEC ESD protection significantly increases the robustness of equipment. Common discharge events occur because of human contact with connectors and cables.

Feature Description (continued)

8.3.2 Electrical Fast Transient (EFT) Protection

Inductive loads such as relays, switch contactors, or heavy-duty motors can create high-frequency bursts during transition. The IEC 61000-4-4 test is intended to simulate the transients created by such switching of inductive loads on AC power lines. Figure 17 shows the voltage waveforms in to 50-Ω termination as defined by the IEC standard.

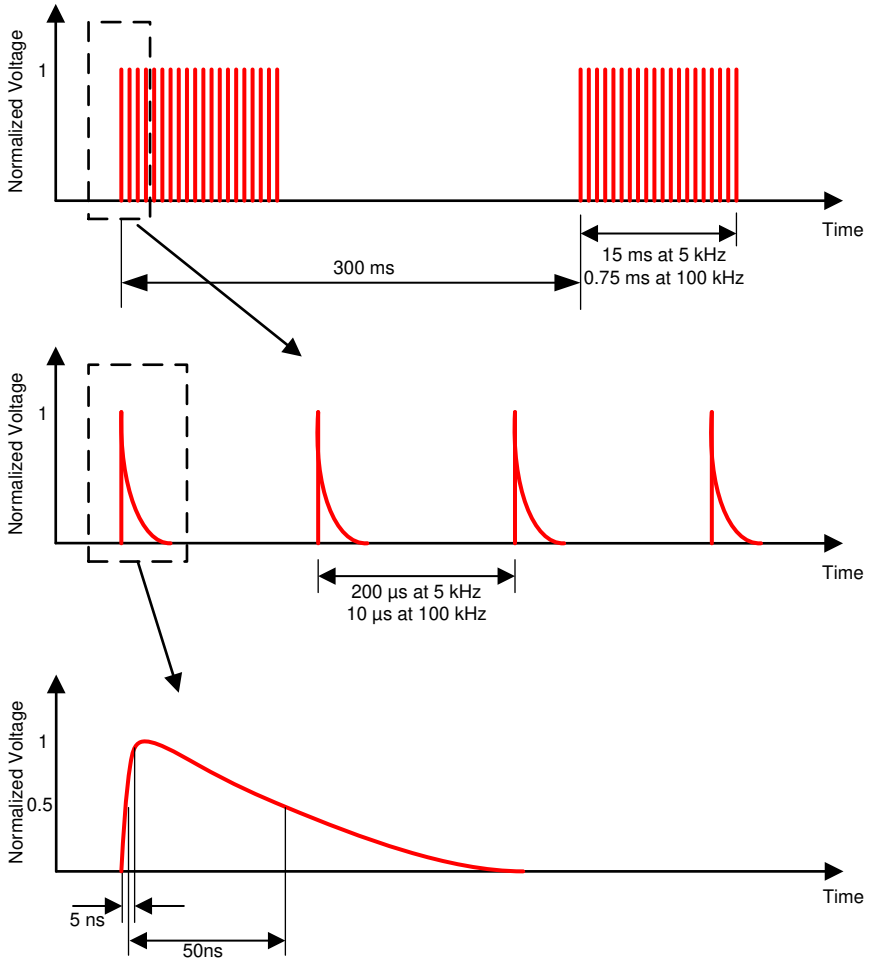


Figure 17. EFT Voltage Waveforms

Internal ESD protection circuits of the THVD1428 protect the transceiver against EFT ±4 kV.

8.3.3 Surge Protection

Surge transients often result from lightning strikes (direct strike or an indirect strike which induce voltages and currents), or the switching of power systems, including load changes and short circuit switching. These transients are often encountered in industrial environments, such as factory automation and power-grid systems.

Figure 18 compares the pulse-power of the EFT and surge transients with the power caused by an IEC ESD transient. The left hand diagram shows the relative pulse-power for a 0.5-kV surge transient and 4-kV EFT transient, both of which dwarf the 10-kV ESD transient visible in the lower-left corner. 500-V surge transients are representative of events that may occur in factory environments in industrial and process automation.

The right hand diagram shows the pulse-power of a 6-kV surge transient, relative to the same 0.5-kV surge transient. 6-kV surge transients are most likely to occur in power generation and power-grid systems.

Feature Description (continued)

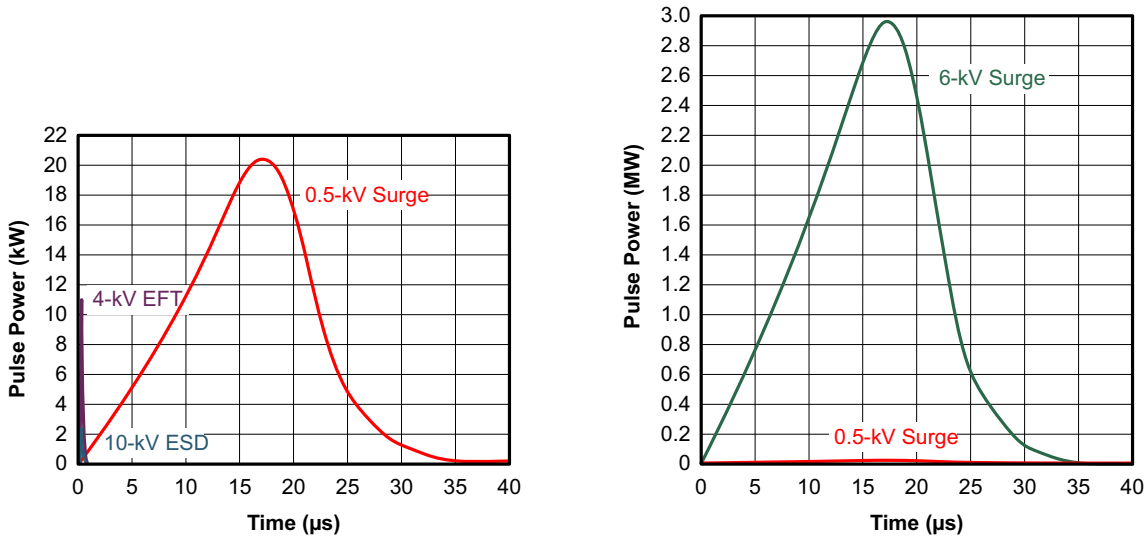


Figure 18. Power Comparison of ESD, EFT, and Surge Transients

Figure 19 shows the test setup used to validate THVD1428 surge performance according to the IEC 61000-4-5 1.2/50-µs surge pulse.

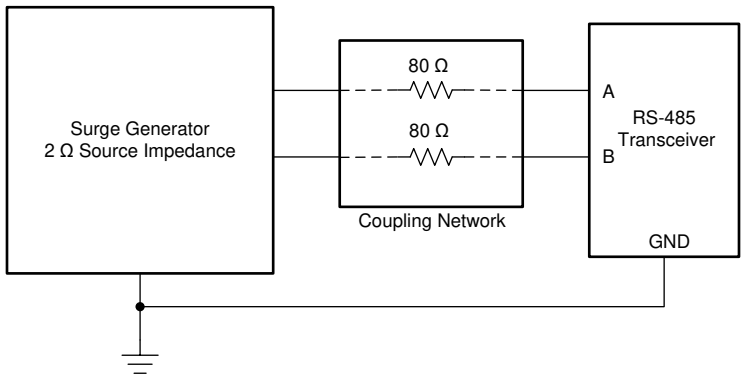


Figure 19. THVD1428 Surge Test Setup

THVD1428 is robust to ±3-kV surge transients without the need for any external components.

8.3.4 Failsafe Receiver

The differential receiver of THVD1428 is failsafe to invalid bus states caused by the following:

- Open bus conditions, such as a disconnected connector
- Shorted bus conditions, such as cable damage shorting the twisted-pair together
- Idle bus conditions that occur when no driver on the bus is actively driving

In any of these cases, the differential receiver outputs a failsafe logic high state so that the output of the receiver is not indeterminate.

8.4 Device Functional Modes

When the driver enable pin, DE, is logic high, the differential outputs A and B follow the logic states at data input D. A logic high at D causes A to turn high and B to turn low. In this case the differential output voltage defined as $V_{OD} = V_A – V_B$ is positive. When D is low, the output states reverse: B turns high, A becomes low, and V_{OD} is negative.

When DE is low, both outputs turn high-impedance. In this condition the logic state at D is irrelevant. The DE pin has an internal pull-down resistor to ground, thus when left open the driver is disabled (high-impedance) by default. The D pin has an internal pull-up resistor of 2-MΩ to V_{CC}, thus, when left open while the driver is enabled, output A turns high and B turns low.

Table 1. Driver Function Table

INPUT	ENABLE	OUTPUTS		FUNCTION
D	DE	A	B	
H	H	H	L	Actively drive bus high
L	H	L	H	Actively drive bus low
X	L	Z	Z	Driver disabled
X	OPEN	Z	Z	Driver disabled by default
OPEN	H	H	L	Actively drive bus high by default

When the receiver enable pin, $\overline{RE}$, is logic low, the receiver is enabled. When the differential input voltage defined as $V_{ID} = V_A – V_B$ is higher than the positive input threshold, V_{TH+}, the receiver output, R, turns high. When V_{ID} is lower than the negative input threshold, V_{TH-}, the receiver output, R, turns low. If V_{ID} is between V_{TH+} and V_{TH-} the output is indeterminate.

When $\overline{RE}$ is logic high or left open, the receiver output is high-impedance and the magnitude and polarity of V_{ID} are irrelevant. Internal biasing of the receiver inputs causes the output to go failsafe-high when the transceiver is disconnected from the bus (open-circuit), the bus lines are shorted to one another (short-circuit), or the bus is not actively driven (idle bus).

Table 2. Receiver Function Table

DIFFERENTIAL INPUT	ENABLE	OUTPUT	FUNCTION
$V_{ID} = V_A – V_B$	$\overline{RE}$	R	
$V_{TH+} < V_{ID}$	L	H	Receive valid bus high
$V_{TH-} < V_{ID} < V_{TH+}$	L	?	Indeterminate bus state
$V_{ID} < V_{TH-}$	L	L	Receive valid bus low
X	H	Z	Receiver disabled
X	OPEN	Z	Receiver disabled by default
Open-circuit bus	L	H	Fail-safe high output
Short-circuit bus	L	H	Fail-safe high output
Idle (terminated) bus	L	H	Fail-safe high output

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

THVD1428 is a half-duplex RS-485 transceiver with integrated system-level surge protection. Standard 8-pin SOIC (D) package allows drop-in replacement into existing systems and eliminate system-level protection components.

9.2 Typical Application

An RS-485 bus consists of multiple transceivers connecting in parallel to a bus cable. To eliminate line reflections, each cable end is terminated with a termination resistor, R_T, whose value matches the characteristic impedance, Z_0, of the cable. This method, known as parallel termination, allows for higher data rates over longer cable length.

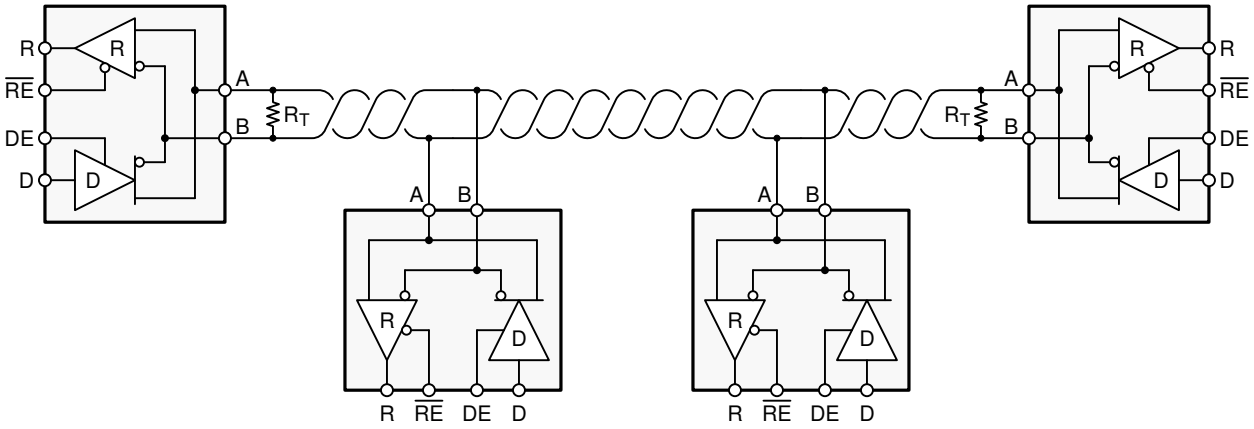


Figure 20. Typical RS-485 Network With Half-Duplex Transceivers

9.2.1 Design Requirements

RS-485 is a robust electrical standard suitable for long-distance networking that may be used in a wide range of applications with varying requirements, such as distance, data rate, and number of nodes.

9.2.1.1 Data Rate and Bus Length

There is an inverse relationship between data rate and cable length, which means the higher the data rate, the short the cable length; and conversely, the lower the data rate, the longer the cable length. While most RS-485 systems use data rates between 10 kbps and 100 kbps, some applications require data rates up to 250 kbps at distances of 4000 feet and longer. Longer distances are possible by allowing for small signal jitter of up to 5 or 10%.

Typical Application (continued)

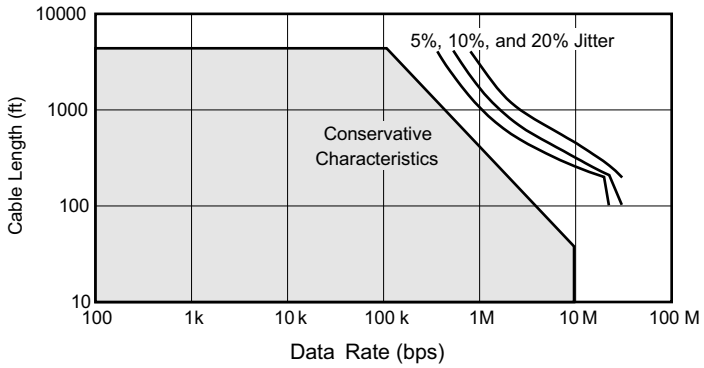


Figure 21. Cable Length vs Data Rate Characteristic

Even higher data rates are achievable (that is, 20 Mbps for the THVD1428) in cases where the interconnect is short enough (or has suitably low attenuation at signal frequencies) to not degrade the data.

9.2.1.2 Stub Length

When connecting a node to the bus, the distance between the transceiver inputs and the cable trunk, known as the stub, should be as short as possible. Stubs present a non-terminated piece of bus line which can introduce reflections as the length of the stub increases. As a general guideline, the electrical length, or round-trip delay, of a stub should be less than one-tenth of the rise time of the driver, thus giving a maximum physical stub length as shown in Equation 1.

$$L_{(STUB)} \leq 0.1 \times t_r \times v \times c \quad (1)$$

where

- t_r is the 10/90 rise time of the driver
- c is the speed of light (3×10^8 m/s)
- v is the signal velocity of the cable or trace as a factor of c

9.2.1.3 Bus Loading

The RS-485 standard specifies that a compliant driver must be able to driver 32 unit loads (UL), where 1 unit load represents a load impedance of approximately 12 kΩ. Because the THVD1428 device consists of 1/8 UL transceiver, connecting up to 256 receivers to the bus is possible.

Typical Application (continued)

9.2.2 Detailed Design Procedure

RS-485 transceivers operate in noisy industrial environments typically require surge protection at the bus pins. Figure 22 compares 1-kV surge protection implementation with a regular RS-485 transceiver (such as THVD14x0) against with the THVD1428. The internal TVS protection of the THVD1428 achieves ±3 kV IEC 61000-4-5 surge protection without any additional external components, reducing system level bill of materials.

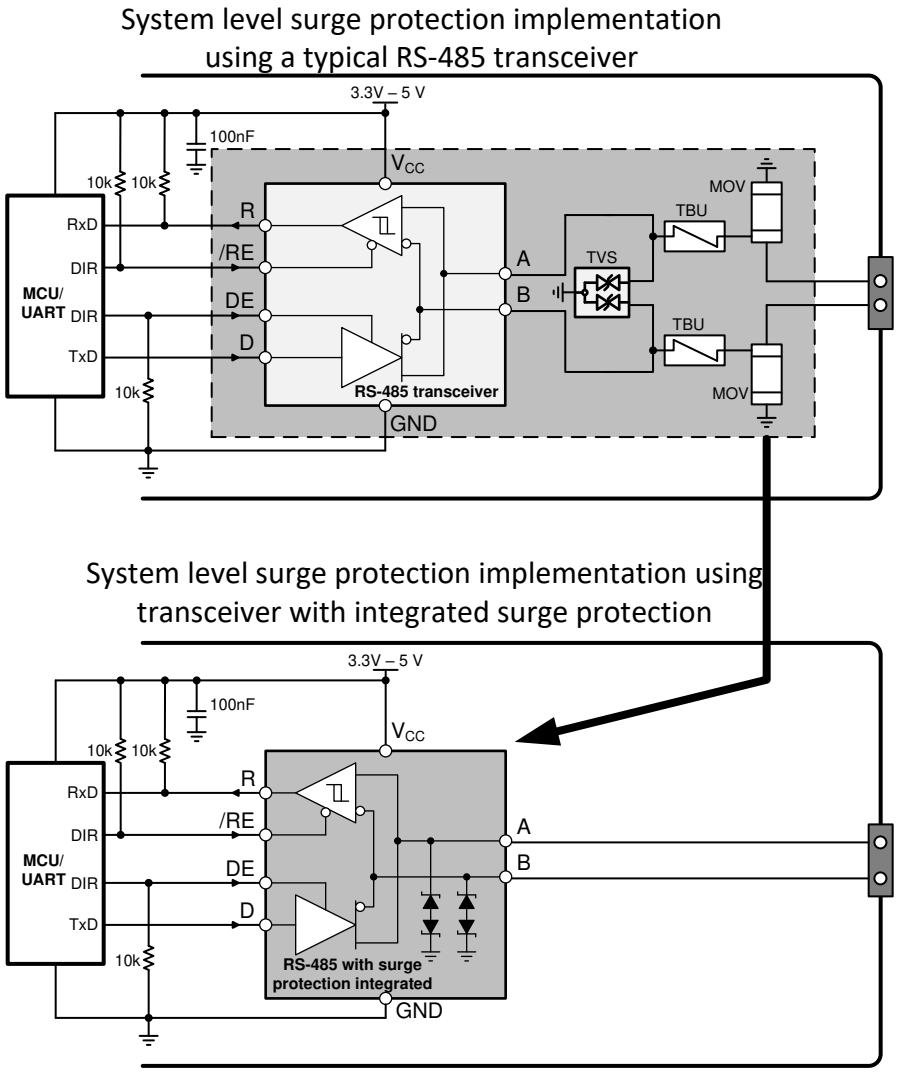
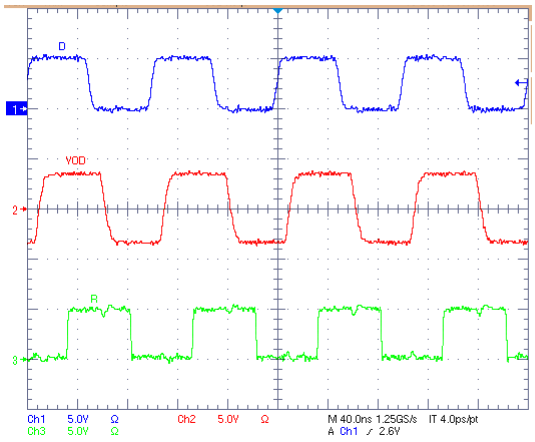


Figure 22. Implementation of System-Level Surge Protection Using THVD1428

Typical Application (continued)

9.2.3 Application Curves



V_{CC} = 5 V 54-Ω Termination T_A = 25°C

Figure 23. THVD1428 Waveforms at 20 Mbps

10 Power Supply Recommendations

To ensure reliable operation at all data rates and supply voltages, each supply should be decoupled with a 100-nF ceramic capacitor located as close to the supply pins as possible. This helps to reduce supply voltage ripple present on the outputs of switched-mode power supplies and also helps to compensate for the resistance and inductance of the PCB power planes.

11 Layout

11.1 Layout Guidelines

Additional external protection components generally are not needed when using THVD1428 transceivers.

1. Use V_{CC} and ground planes to provide low-inductance. Note that high-frequency currents tend to follow the path of least impedance and not the path of least resistance. Apply 100-nF to 220-nF decoupling capacitors as close as possible to the V_{CC} pins of transceiver, UART and/or controller ICs on the board.
2. Use at least two vias for V_{CC} and ground connections of decoupling capacitors to minimize effective via-inductance.
3. Use 1-kΩ to 10-kΩ pull-up and pull-down resistors for enable lines to limit noise currents in theses lines during transient events.

11.2 Layout Example

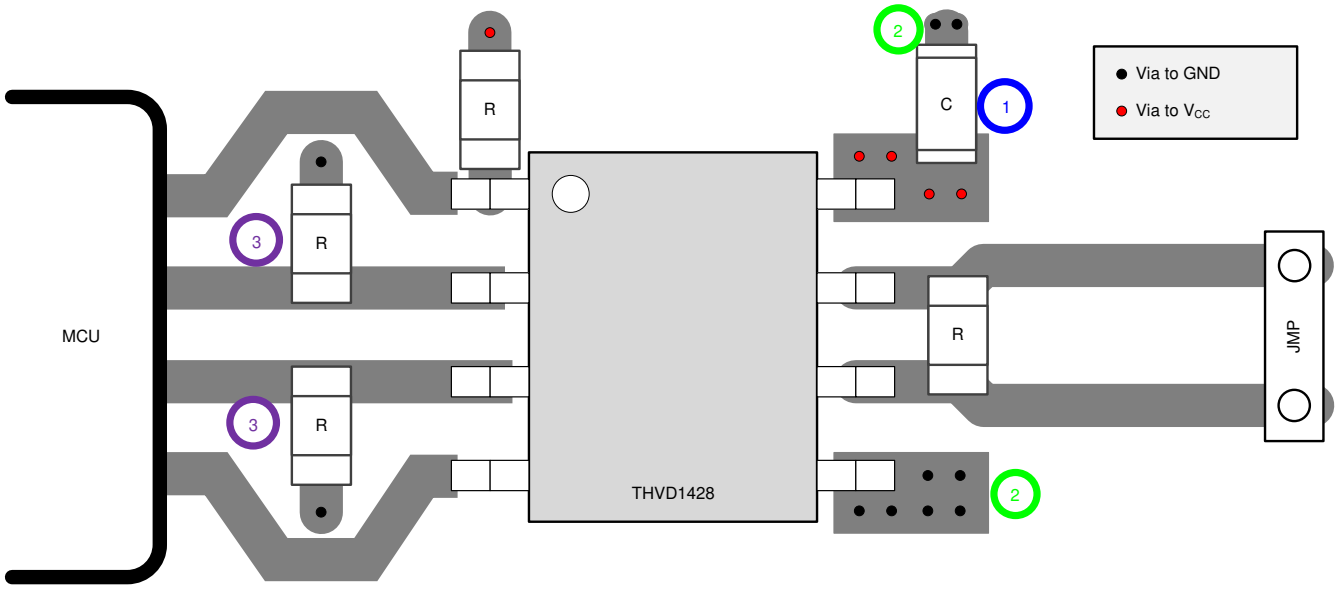


Figure 24. Half-Duplex Layout Example

12 Device and Documentation Support

12.1 Device Support

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

12.4 Trademarks

E2E is a trademark of Texas Instruments.

12.5 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
THVD1428DR	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	Yes	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	1428
THVD1428DR.B	Active	Production	SOIC (D) | 8	2500 | LARGE T&R	-	Call TI	Call TI	-40 to 125	

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

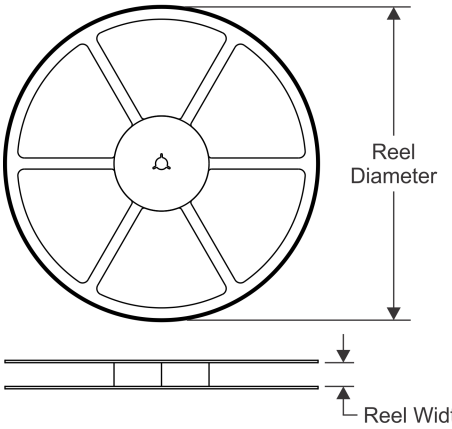
(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

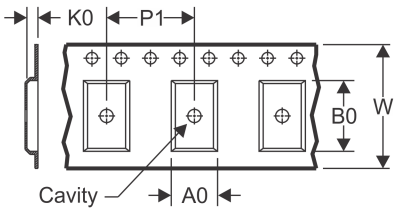
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

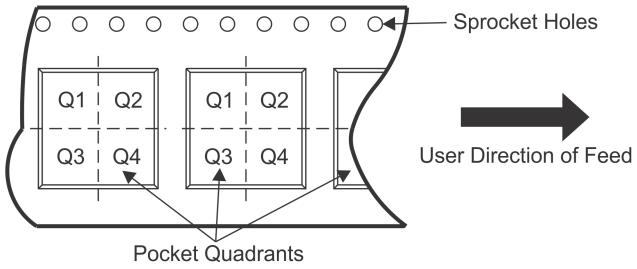


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

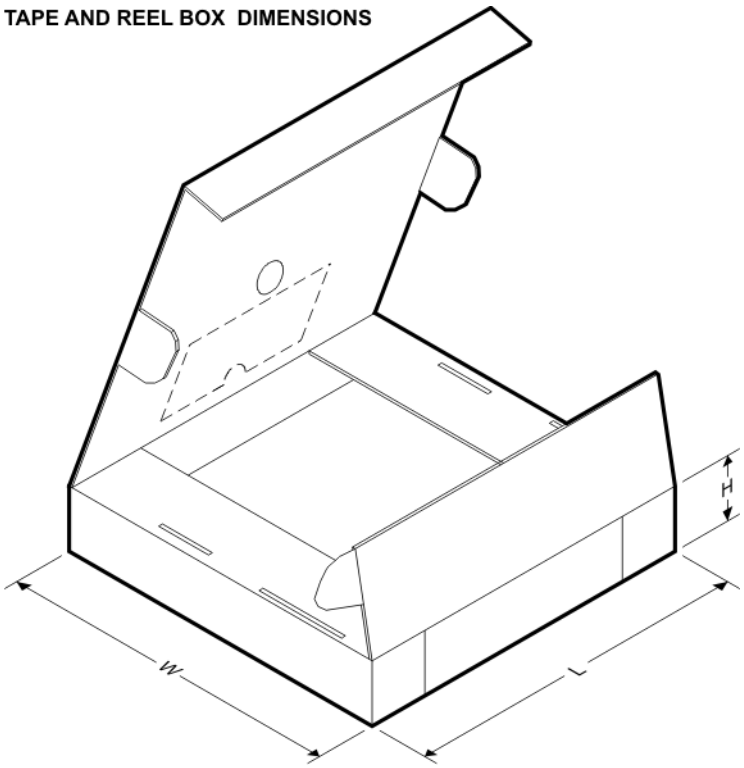
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

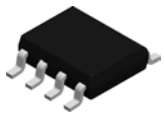
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
THVD1428DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
THVD1428DR	SOIC	D	8	2500	346.0	346.0	29.0

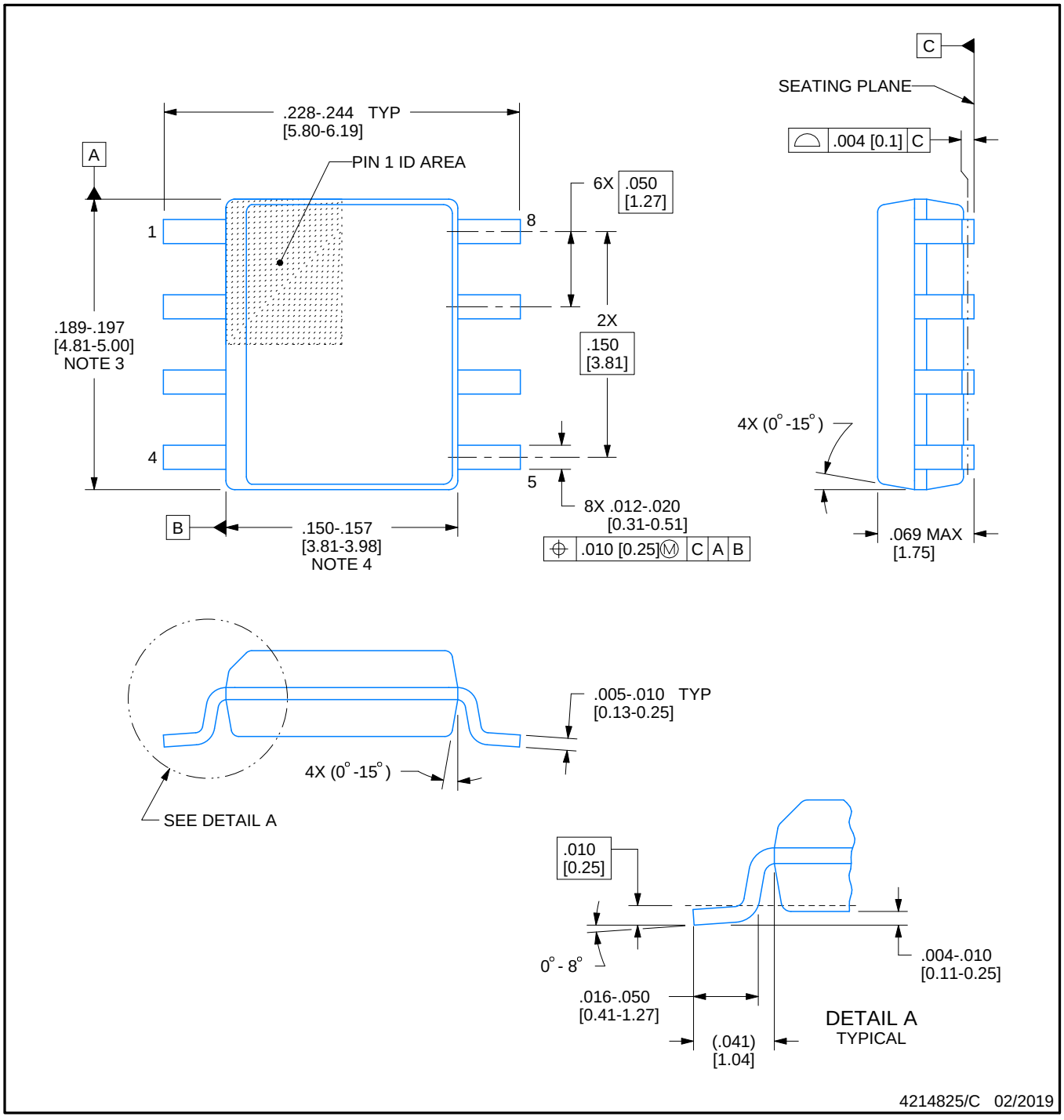


PACKAGE OUTLINE

D0008A

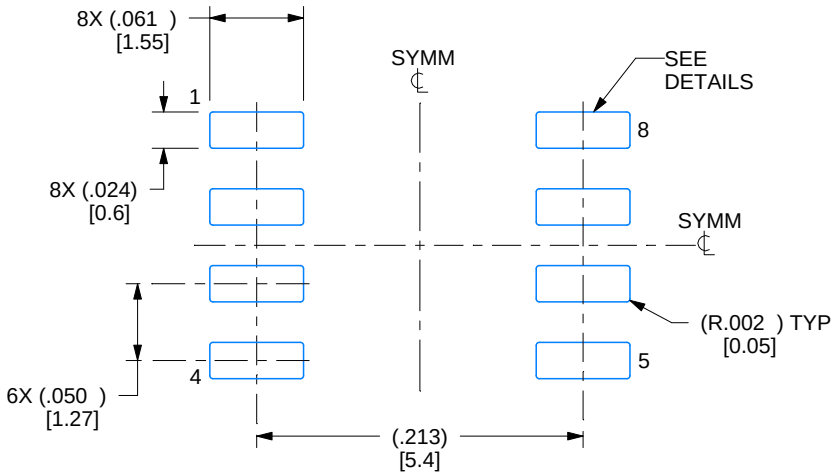
SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

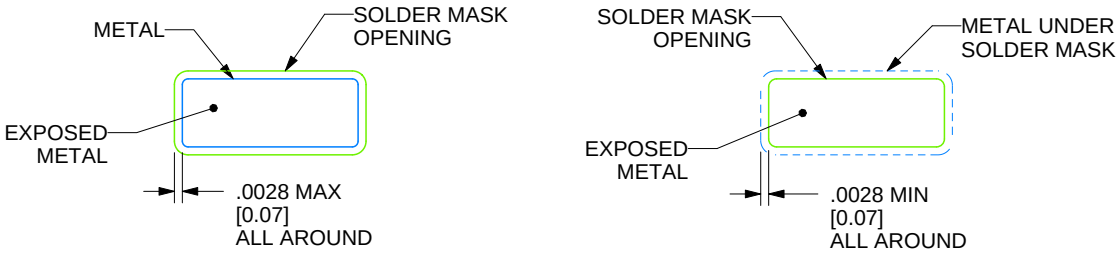


NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

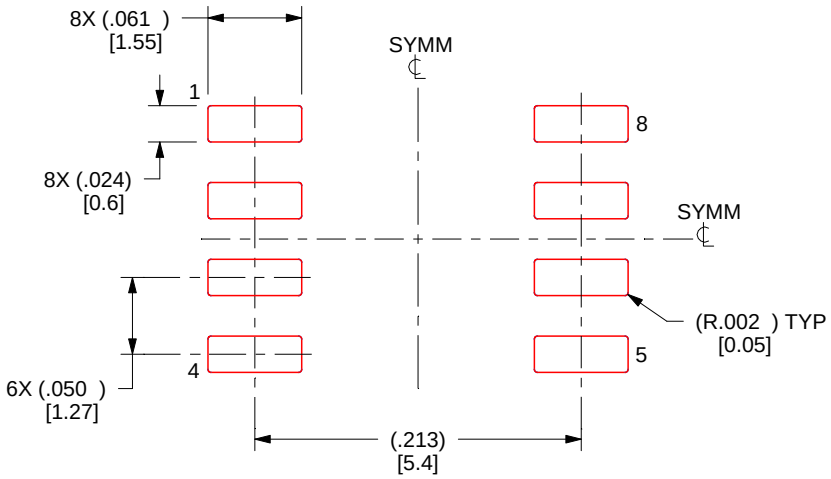
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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Last updated 10/2025